STP17N80K5



N-channel 800 V, 0.29 Ω typ., 14 A MDmesh™ K5 Power MOSFET in a TO-220 package

Datasheet - production data

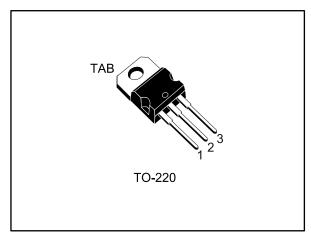
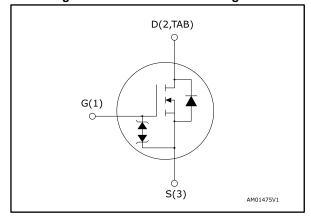


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	I _D
STP17N80K5	800 V	0.34 Ω	14 A

- Industry's lowest R_{DS(on)} x area
- Industry's best FoM (figure of merit)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

This very high voltage N-channel Power MOSFET is designed using MDmesh™ K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing
STP17N80K5	17N80K5	TO-220	Tube

Contents STP17N80K5

Contents

1	Electric	cal ratings	3
2	Electric	cal characteristics	4
	2.1	Electrical characteristics (curves)	6
3	Test cir	·cuits	8
4	Packag	e information	9
	4.1	TO-220 type A package information	10
5	Revisio	on history	12

STP17N80K5 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit	
V_{GS}	Gate-source voltage	± 30	V	
I_D	Drain current (continuous) at T _C = 25 °C	14	Α	
I _D	Drain current (continuous) at T _C = 100 °C	9	Α	
I _{DM} ⁽¹⁾	Drain current (pulsed)	56	Α	
P _{TOT}	Total dissipation at T _C = 25 °C	170	W	
dv/dt (2)	Peak diode recovery voltage slope	4.5	V/ns	
dv/dt (3)	MOSFET dv/dt ruggedness	50 V		
TJ	Operating junction temperature range	FF to 150	°C	
T _{stg}	Storage temperature range	- 55 to 150 °C		

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	0.74	°C/W
R _{thj-amb}	Thermal resistance junction-ambient	62.5	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T _{jmax})	4.7	Α
E _{AS}	Single pulse avalanche energy (starting Tj = 25 °C, $I_D = I_{AR}$, $V_{DD} = 50 \text{ V}$)	340	mJ

 $^{^{(1)}}$ Pulse width limited by safe operating area

 $^{^{(2)}}I_{SD} \leq$ 14 A, di/dt = 100 A/ μ s; V_{DS} peak < V_{(BR)DSS},V_{DD}= 640 V

 $^{^{(3)}}V_{DS} \le 640 \text{ V}$

Electrical characteristics STP17N80K5

2 Electrical characteristics

T_C = 25 °C unless otherwise specified

Table 5: On/off-state

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_{D} = 1 \text{ mA}$	800			٧
		$V_{GS} = 0 \text{ V}, V_{DS} = 800 \text{ V}$			1	μΑ
I _{DSS}	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 800 \text{ V}$ $T_{C} = 125 ^{\circ}\text{C}^{(1)}$			50	μΑ
I _{GSS}	Gate body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DD} = V_{GS}, I_D = 250 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 7 \text{ A}$		0.29	0.34	Ω

Notes:

Table 6: Dynamic

Table of Dynamic							
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
C _{iss}	Input capacitance		-	866	-	pF	
Coss	Output capacitance	$V_{DS} = 100 \text{ V}, f = 1 \text{ MHz}, $ $V_{GS} = 0 \text{ V}$	-	64	-	pF	
C _{rss}	Reverse transfer capacitance	, vgs – 0 v	-	0.42	-	pF	
C _{o(tr)} ⁽¹⁾	Equivalent capacitance time related	V _{DS} = 0 to 640 V,	-	142	-	pF	
C _{o(er)} ⁽²⁾	Equivalent capacitance energy related	$V_{GS} = 0 V$	1	51	-	pF	
Rg	Intrinsic gate resistance	f = 1 MHz , I _D = 0 A	-	5	-	Ω	
Qg	Total gate charge	V _{DD} = 640 V, I _D = 14 A	-	26	-	nC	
Q_{gs}	Gate-source charge	V _{GS} = 10 V	-	7.2	-	nC	
Q_{gd}	Gate-drain charge	(see Figure 15: "Test circuit for gate charge behavior")	-	15.2	-	nC	

Notes:

⁽¹⁾Defined by design, not subject to production test.

 $^{^{(1)}}$ C_{o(tr)} is a constant capacitance value that gives the same charging time as Coss while V_{DS} is rising from 0 to 80% V_{DSS}.

 $^{^{(2)}}$ C_{o(er)} is a constant capacitance value that gives the same stored energy as Coss while V_{DS} is rising from 0 to 80% V_{DSS}.

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	V_{DD} = 400 V, I_D =7 A, R_G = 4.7 Ω	ı	14.8	•	ns
t _r	Rise time	V _{GS} = 10 V	ı	10.8	ı	ns
t _{d(off)}	Turn-off delay time	(see Figure 14: "Test circuit for resistive load switching times"	-	84.3	-	ns
t _f	Fall time	and Figure 19: "Switching time waveform")	-	10.1	-	ns

Table 8: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		14	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		56	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 14 A, V _{GS} = 0 V	-		1.6	V
t _{rr}	Reverse recovery time	I _{SD} = 14 A, di/dt = 100 A/μs,	-	439		ns
Q _{rr}	Reverrse recovery charge	$V_{DD} = 60 \text{ V}$ (see Figure 16: "Test circuit for	-	6.37		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")	-	29		Α
t _{rr}	Reverse recovery time	I _{SD} = 14 A, di/dt = 100 A/μs,	-	626		ns
Qrr	Reverse recovery charge	$V_{DD} = 60 \text{ V}, T_j = 150 \text{ °C}$ (see Figure 16: "Test circuit for	-	8.36		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")	-	26.7		А

Notes:

Table 9: Gate-source Zener diode

Syml	bol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _(BR)	GSO	Gate-source breakdown voltage	I_{GS} = ± 1 mA, I_{D} = 0 A	30	ı	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.

 $^{^{(1)}}$ Pulse width limited by safe operating area

 $^{^{(2)}\}text{Pulsed:}$ pulse duration = 300 $\mu\text{s,}$ duty cycle 1.5%

2.2 Electrical characteristics (curves)

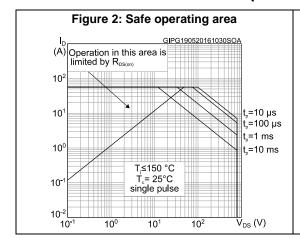


Figure 3: Thermal impedance

K

0.2

0.1

10-1

0.05

0.02

Zth= K'Rthj-c

5 = tp/T

10-5

10-5

10-4

10-3

10-2

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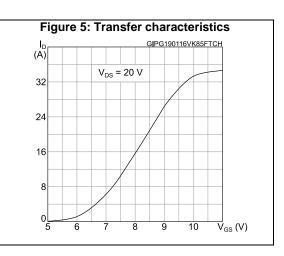
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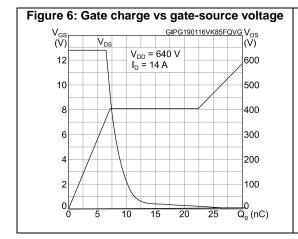
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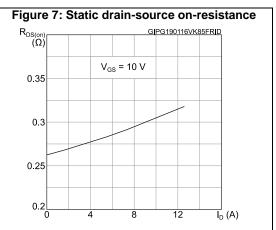
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STP17N80K5 Electrical characteristics

Figure 8: Capacitance variations

C
(pF)

10³

10²

C
10¹

f = 1 MHz

10⁰

10⁻¹

10⁻¹

10⁻¹

10⁰

10¹

10²

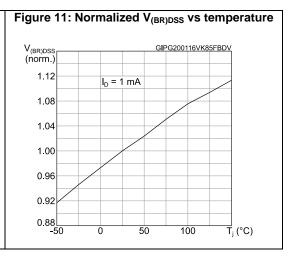
V_{DS} (V)

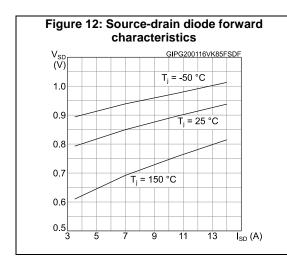
Figure 10: Normalized on-resistance vs temperature

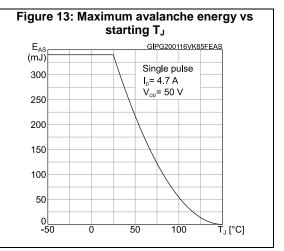
R_{DS(on)} GIPG200116VK85FRON

2.6 V_{GS} = 10 V

2.2 1.8 1.4 1.0 0.6 0.2 0.2 0.50 100 T_j (°C)







Test circuits STP17N80K5

3 Test circuits

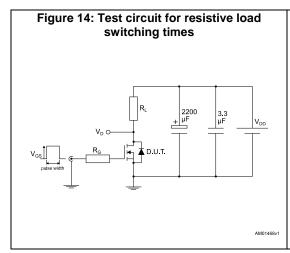


Figure 15: Test circuit for gate charge behavior

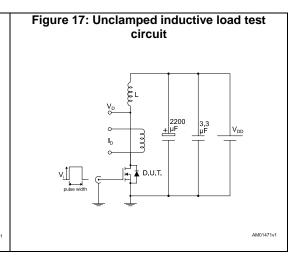
12 V 47 kΩ 100 nF 1 kΩ

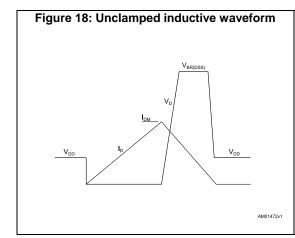
V_{GS} 1 kΩ 1 kΩ

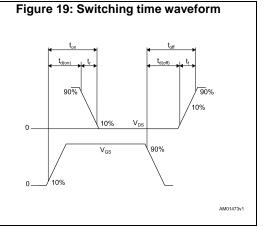
V_{GS} 1 kΩ 1 kΩ

AM01466v1

Figure 16: Test circuit for inductive load switching and diode recovery times







STP17N80K5 Package information

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 TO-220 type A package information

Figure 20: TO-220 type A package outline

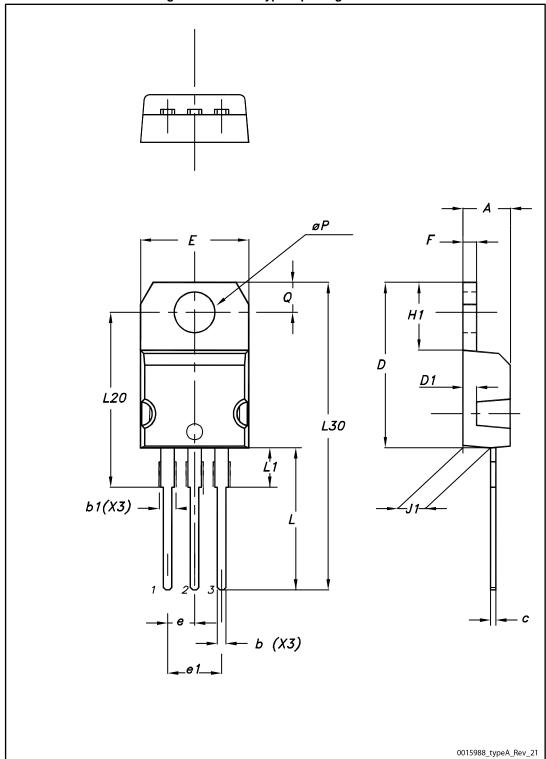


Table 10: TO-220 type A mechanical data

	mm					
Dim.	Min.	Тур.	Max.			
А	4.40		4.60			
b	0.61		0.88			
b1	1.14		1.55			
С	0.48		0.70			
D	15.25		15.75			
D1		1.27				
Е	10.00		10.40			
е	2.40		2.70			
e1	4.95		5.15			
F	1.23		1.32			
H1	6.20		6.60			
J1	2.40		2.72			
L	13.00		14.00			
L1	3.50		3.93			
L20		16.40				
L30		28.90				
øΡ	3.75		3.85			
Q	2.65		2.95			

Revision history STP17N80K5

5 Revision history

Table 11: Document revision history

Date	Revision	Changes
03-Apr-2015	1	First release.
		Modified: Table 2: "Absolute maximum ratings", Table 3: "Thermal data"
19-May-2016	2	Added: Section 3.1: "Electrical characteristics (curves)"
		Minor text changes

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